

### TFT-LCD Power Supply

The EL7586 and EL7586A represent multiple output regulators for use in all large panel, TFT-LCD applications. Both feature a single boost converter with an integrated 2A FET, two positive LDOs for  $V_{ON}$  and  $V_{LOGIC}$  generation, and a single negative LDO for  $V_{OFF}$  generation. The boost converter can be programmed to operate in either P-mode or PI-mode for improved load regulation.

Both EL7586 and EL7586A also integrate fault protection for all four channels. Once a fault is detected, the device is latched off until the input supply or EN is cycled. EL7586 also features an integrated start-up sequence for  $V_{BOOST}/V_{LOGIC}$ ,  $V_{OFF}$ , then  $V_{ON}$  or for  $V_{LOGIC}$ ,  $V_{OFF}$ ,  $V_{BOOST}$ , and  $V_{ON}$ . The latter requires a single external transistor. The timing of the start-up sequence is set using an external capacitor.

EL7586A features an immediately-enabled  $V_{LOGIC}$  output which is independent of EN input. The  $V_{LOGIC}$  output will be switched off if a fault is detected and the power supply needs to be recycled to reset this condition.

Both the EL7586 and EL7586A are pin-compatible, come in the 20 Ld 4x4 QFN package, and are specified for operation over the  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  temperature range.

### Ordering Information

PART NUMBER	PART MARKING	TAPE & REEL	PACKAGE	PKG. DWG. #
EL7586ILZ (Note)	7586ILZ	-	20 Ld 4x4 QFN (Pb-free)	MDP0046
EL7586ILZ-T7 (Note)	7586ILZ	7"	20 Ld 4x4 QFN (Pb-free)	MDP0046
EL7586ILZ-T13 (Note)	7586ILZ	13"	20 Ld 4x4 QFN (Pb-free)	MDP0046
EL7586AILZ (Note)	7586AIL Z	-	20 Ld 4x4 QFN (Pb-free)	MDP0046
EL7586AILZ-T7 (Note)	7586AIL Z	7"	20 Ld 4x4 QFN (Pb-free)	MDP0046
EL7586AILZ-T13 (Note)	7586AIL Z	13"	20 Ld 4x4 QFN (Pb-free)	MDP0046

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

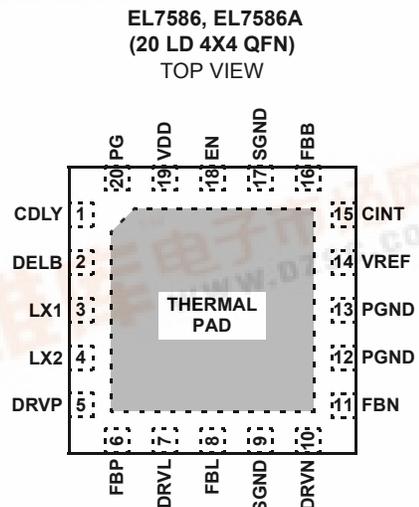
### Features

- 2A current limit FET options
- 3V to 5V input
- Up to 20V boost out
- 1% regulation on all outputs
- $V_{LOGIC}$ - $V_{OFF}$ - $V_{BOOST}$ - $V_{ON}$  or  $V_{BOOST}/V_{LOGIC}$ - $V_{OFF}$ - $V_{ON}$  sequence control
  - $V_{LOGIC}$  is on from start-up for EL7586A
- Programmable sequence delay
- Fully fault protected
- Thermal shutdown
- Internal soft-start
- 20 Ld 4x4 QFN packages
- Pb-free plus anneal available (RoHS compliant)

### Applications

- LCD monitors (15"+)
- LCD-TV (up to 40"+)
- Notebook displays (up to 16")
- Industrial/medical LCD displays

### Pinout



## EL7586, EL7586A

### Absolute Maximum Ratings (T<sub>A</sub> = 25°C)

V <sub>DELB</sub> .....	.24V	V <sub>DRVL</sub> .....	6.5V
V <sub>DRVP</sub> .....	.36V	Storage Temperature .....	-65°C to +150°C
V <sub>DRVN</sub> .....	-20V	Ambient Operating Temperature .....	-40°C to +85°C
V <sub>DD</sub> .....	6.5V	Power Dissipation .....	See Curves
V <sub>LX</sub> .....	.24V	Maximum Continuous Junction Temperature .....	125°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore: T<sub>J</sub> = T<sub>C</sub> = T<sub>A</sub>

**Electrical Specifications** V<sub>DD</sub> = 5V, V<sub>BOOST</sub> = 11V, I<sub>LOAD</sub> = 200mA, V<sub>ON</sub> = 15V, V<sub>OFF</sub> = -5V, V<sub>LOGIC</sub> = 2.5V, over temperature from -40°C to 85°C, unless otherwise specified.

PARAMETER	DESCRIPTION	CONDITION	MIN	TYP	MAX	UNIT
<b>SUPPLY</b>						
V <sub>S</sub>	Supply Voltage		3		5.5	V
I <sub>S</sub>	Quiescent Current (EL7586A)	Enabled, LX not switching		1.7	2.5	mA
		Disabled		750	900	μA
I <sub>S</sub>	Quiescent Current (EL7586)	Enabled, LX not switching		1.7	2.5	mA
		Disabled		10	20	μA
<b>CLOCK</b>						
F <sub>OSC</sub>	Oscillator Frequency		900	1000	1100	kHz
<b>BOOST</b>						
V <sub>BOOST</sub>	Boost Output Range		5.5		20	V
V <sub>FBB</sub>	Boost Feedback Voltage	T <sub>A</sub> = 25°C	1.192	1.205	1.218	V
			1.188	1.205	1.222	V
V <sub>F_FBB</sub>	FBB Fault Trip Point			0.9		V
V <sub>REF</sub>	Reference Voltage	T <sub>A</sub> = 25°C	1.19	1.215	1.235	V
			1.187	1.215	1.238	V
C <sub>REF</sub>	V <sub>REF</sub> Capacitor		22	100		nF
D <sub>MAX</sub>	Maximum Duty Cycle		85			%
I <sub>LXMAX</sub>	Current Switch			2.0		A
I <sub>LEAK</sub>	Switch Leakage Current	V <sub>LX</sub> = 16V			10	μA
r <sub>DS(ON)</sub>	Switch On-Resistance			320		mΩ
Eff	Boost Efficiency	See curves	85	92		%
I(V <sub>FBB</sub> )	Feedback Input Bias Current	PI mode, V <sub>FBB</sub> = 1.35V		50	500	nA
ΔV <sub>BOOST</sub> /ΔV <sub>IN</sub>	Line Regulation	C <sub>INT</sub> = 4.7nF, I <sub>OUT</sub> = 100mA, V <sub>IN</sub> = 3V to 5.5V		0.05		%/V
ΔV <sub>BOOST</sub> /ΔI <sub>BOOST</sub>	Load Regulation - "P" Mode	C <sub>INT</sub> pin strapped to V <sub>DD</sub> , 50mA < I <sub>LOAD</sub> < 250mA		3		%
ΔV <sub>BOOST</sub> /ΔI <sub>BOOST</sub>	Load Regulation - "PI" Mode	C <sub>INT</sub> = 4.7nF, 50mA < I <sub>O</sub> < 250mA		0.1		%
V <sub>CINT_T</sub>	CINT PI Mode Select Threshold			4.7	4.8	V

## EL7586, EL7586A

**Electrical Specifications**  $V_{DD} = 5V$ ,  $V_{BOOST} = 11V$ ,  $I_{LOAD} = 200mA$ ,  $V_{ON} = 15V$ ,  $V_{OFF} = -5V$ ,  $V_{LOGIC} = 2.5V$ , over temperature from  $-40^{\circ}C$  to  $85^{\circ}C$ , unless otherwise specified. **(Continued)**

PARAMETER	DESCRIPTION	CONDITION	MIN	TYP	MAX	UNIT
<b>V<sub>ON</sub> LDO</b>						
V <sub>FBP</sub>	FBP Regulation Voltage	I <sub>DRVP</sub> = 0.2mA, T <sub>A</sub> = 25°C	1.176	1.2	1.224	V
		I <sub>DRVP</sub> = 0.2mA	1.172	1.2	1.228	V
V <sub>F_FBP</sub>	FBP Fault Trip Point	V <sub>FBP</sub> falling	0.82	0.87	0.92	V
I <sub>FBP</sub>	FBP Input Bias Current	V <sub>FBP</sub> = 1.35V	-250		250	nA
GMP	FBP Effective Transconductance	V <sub>DRVP</sub> = 25V, I <sub>DRVP</sub> = 0.2 to 2mA		50		ms
$\Delta V_{ON}/\Delta I(V_{ON})$	V <sub>ON</sub> Load Regulation	I(V <sub>ON</sub> ) = 0mA to 20mA		-0.5		%
I <sub>DRVP</sub>	DRVP Sink Current Max	V <sub>FBP</sub> = 1.1V, V <sub>DRVP</sub> = 25V	2	4		mA
I <sub>L_DRVP</sub>	DRVP Leakage Current	V <sub>FBP</sub> = 1.5V, V <sub>DRVP</sub> = 35V		0.1	5	μA
<b>V<sub>OFF</sub> LDO</b>						
V <sub>FBN</sub>	FBN Regulation Voltage	I <sub>DRVN</sub> = 0.2mA, T <sub>A</sub> = 25°C	0.173	0.203	0.233	V
		I <sub>DRVN</sub> = 0.2mA	0.171	0.203	0.235	V
V <sub>F_FBN</sub>	FBN Fault Trip Point	V <sub>FBN</sub> falling	0.38	0.43	0.48	V
I <sub>FBN</sub>	FBN Input Bias Current	V <sub>FBN</sub> = 0.2V	-250		250	nA
GMN	FBN Effective Transconductance	V <sub>DRVN</sub> = -6V, I <sub>DRVN</sub> = 0.2mA to 2mA		50		ms
$\Delta V_{OFF}/\Delta I(V_{OFF})$	V <sub>OFF</sub> Load Regulation	I(V <sub>OFF</sub> ) = 0mA to 20mA		-0.5		%
I <sub>DRVN</sub>	DRVN Source Current Max	V <sub>FBN</sub> = 0.3V, V <sub>DRVN</sub> = -6V	2	4		mA
I <sub>L_DRVN</sub>	DRVN Leakage Current	V <sub>FBN</sub> = 0V, V <sub>DRVN</sub> = -20V		0.1	5	μA
<b>V<sub>LOGIC</sub> LDO</b>						
V <sub>FBL</sub>	FBL Regulation Voltage	I <sub>DRVL</sub> = 1mA, T <sub>A</sub> = 25°C	1.176	1.2	1.224	V
		I <sub>DRVL</sub> = 1mA	1.174	1.2	1.226	V
V <sub>F_FBL</sub>	FBL Fault Trip Point	V <sub>FBL</sub> falling	0.82	0.87	0.92	V
I <sub>FBL</sub>	FBL Input Bias Current	V <sub>FBL</sub> = 1.35V	-500		500	nA
GML	FBL Effective Transconductance	V <sub>DRVL</sub> = 2.5V, I <sub>DRVL</sub> = 1mA to 8mA		200		ms
$\Delta V_{LOGIC}/\Delta I(V_{LOGIC})$	V <sub>LOGIC</sub> Load Regulation	I(V <sub>LOGIC</sub> ) = 100mA to 500mA		0.5		%
I <sub>DRVL</sub>	DRVL Sink Current Max	V <sub>FBL</sub> = 1.1V, V <sub>DRVL</sub> = 2.5V	8	16		mA
I <sub>L_DRL</sub>	I <sub>L_DRVL</sub>	V <sub>FBL</sub> = 1.5V, V <sub>DRVL</sub> = 5.5V		0.1	5	μA
<b>SEQUENCING</b>						
t <sub>ON</sub>	Turn On Delay	C <sub>DLY</sub> = 0.22μF		30		ms
t <sub>SS</sub>	Soft-start Time	C <sub>DLY</sub> = 0.22μF		2		ms
t <sub>DEL1</sub>	Delay Between A <sub>VDD</sub> and V <sub>OFF</sub>	C <sub>DLY</sub> = 0.22μF		10		ms
t <sub>DEL2</sub>	Delay Between V <sub>ON</sub> and V <sub>OFF</sub>	C <sub>DLY</sub> = 0.22μF		17		ms
I <sub>DELB</sub>	DELB Pull-down Current	V <sub>DELB</sub> > 0.6V		50		μA
		V <sub>DELB</sub> < 0.6V		1.4		mA
C <sub>DEL</sub>	Delay Capacitor		10	220		nF

## EL7586, EL7586A

**Electrical Specifications**  $V_{DD} = 5V$ ,  $V_{BOOST} = 11V$ ,  $I_{LOAD} = 200mA$ ,  $V_{ON} = 15V$ ,  $V_{OFF} = -5V$ ,  $V_{LOGIC} = 2.5V$ , over temperature from  $-40^{\circ}C$  to  $85^{\circ}C$ , unless otherwise specified. **(Continued)**

PARAMETER	DESCRIPTION	CONDITION	MIN	TYP	MAX	UNIT
<b>FAULT DETECTION</b>						
$t_{FAULT}$	Fault Time Out	$C_{DLY} = 0.22\mu F$		50		ms
OT	Over-temperature Threshold			140		$^{\circ}C$
$I_{PG}$	PG Pull-down Current	$V_{PG} > 0.6V$		15		$\mu A$
		$V_{PG} < 0.6V$		1.7		mA
<b>LOGIC ENABLE</b>						
$V_{HI}$	Logic High Threshold		2.3			V
$V_{LO}$	Logic Low Threshold				0.8	V
$I_{LOW}$	Logic Low Bias Current			0.2	2	$\mu A$
$I_{HIGH}$	Logic High Bias Current	at $V_{EN} = 5V$	12	18	24	$\mu A$

### Pin Descriptions

PIN NAME	PIN NUMBER	DESCRIPTION
1	CDLY	A capacitor connected from this pin to GND sets the delay time for start-up sequence and sets the fault timeout time
2	DELB	Gate drive of optional $V_{BOOST}$ delay FET
3, 4	LX1, LX2	Drain of the internal N channel boost FET; for EL7586, pin 4 is not connected
5	DRVP	Positive LDO base drive; open drain of an internal N channel FET
6	FBP	Positive LDO voltage feedback input pin; regulates to 1.2V nominal
7	DRVL	Logic LDO base drive; open drain of an internal N channel FET
8	FBL	Logic LDO voltage feedback input pin; regulates to 1.2V nominal
9, 17	SGND	Low noise signal ground
10	DRVN	Negative LDO base drive; open drain of an internal P channel FET
11	FBN	Negative LDO voltage feedback input pin; regulates to 0.2V nominal
12, 13	PGND	Power ground, connected to source of internal N channel boost FET
14	VREF	Bandgap voltage bypass, connect a $0.1\mu F$ to SGND
15	CINT	$V_{BOOST}$ integrator output, connect capacitor to SGND for PI mode or connect to $V_{DD}$ for P mode operation
16	FBB	Boost regulator voltage feedback input pin; regulates to 1.2V nominal
18	EN	Enable pin, High = Enable; Low or floating = Disable
19	VDD	Positive supply
20	PG	Gate drive of optional fault protection FET, when chip is disabled or when a fault has been detected, this is high

Typical Performance Curves

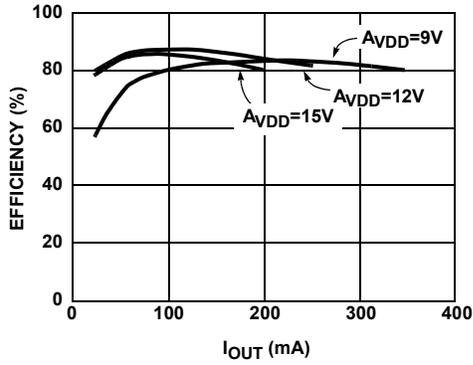


FIGURE 1. V<sub>BOOST</sub> EFFICIENCY AT V<sub>IN</sub> = 3V (PI MODE)

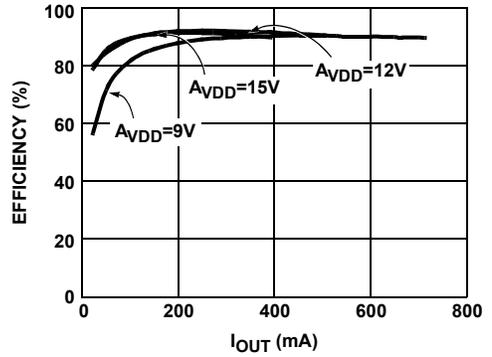


FIGURE 2. V<sub>BOOST</sub> EFFICIENCY AT V<sub>IN</sub> = 5V (PI MODE)

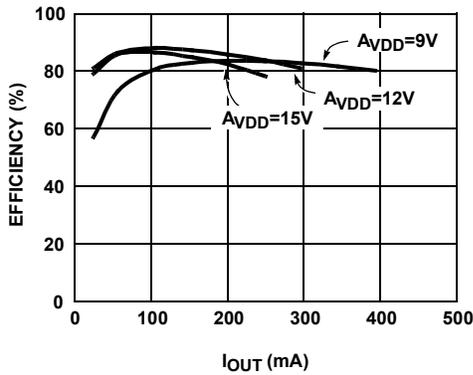


FIGURE 3. V<sub>BOOST</sub> EFFICIENCY AT V<sub>IN</sub> = 3V (P MODE)

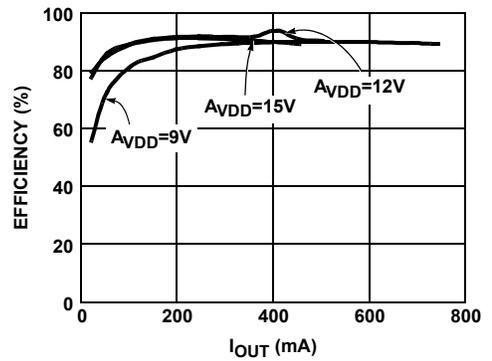


FIGURE 4. V<sub>BOOST</sub> EFFICIENCY AT V<sub>IN</sub> = 5V (P MODE)

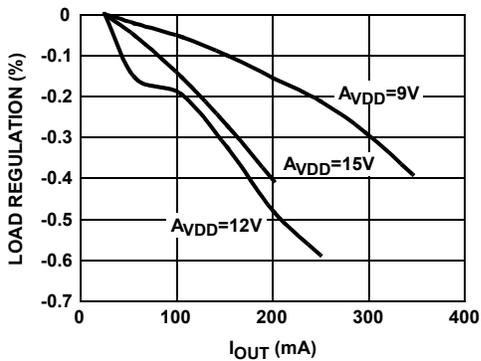


FIGURE 5. V<sub>BOOST</sub> LOAD REGULATION AT V<sub>IN</sub> = 3V (PI MODE)

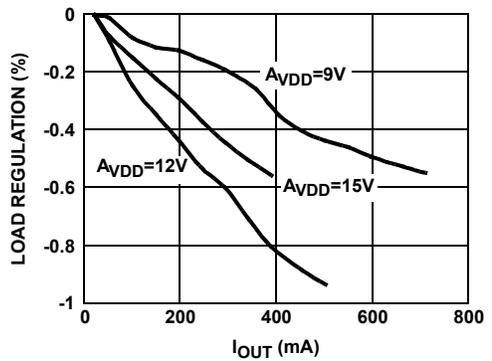


FIGURE 6. V<sub>BOOST</sub> LOAD REGULATION AT V<sub>IN</sub> = 5V (PI MODE)

Typical Performance Curves (Continued)

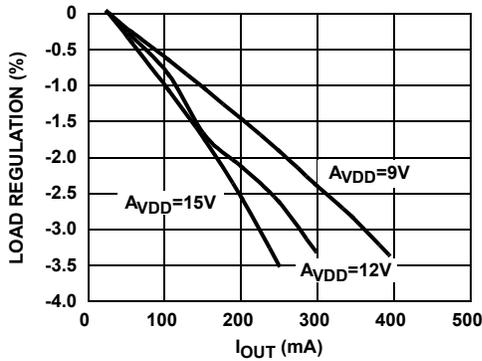


FIGURE 7.  $V_{\text{BOOST}}$  LOAD REGULATION AT  $V_{\text{IN}} = 3\text{V}$  (P MODE)

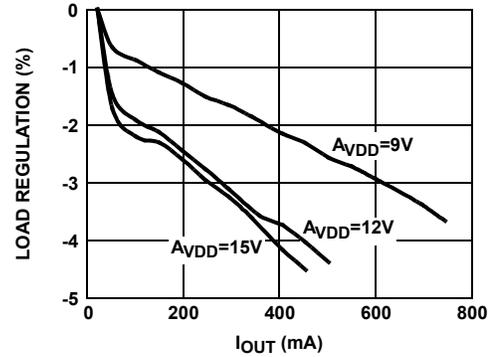


FIGURE 8.  $V_{\text{BOOST}}$  LOAD REGULATION AT  $V_{\text{IN}} = 5\text{V}$  (P MODE)

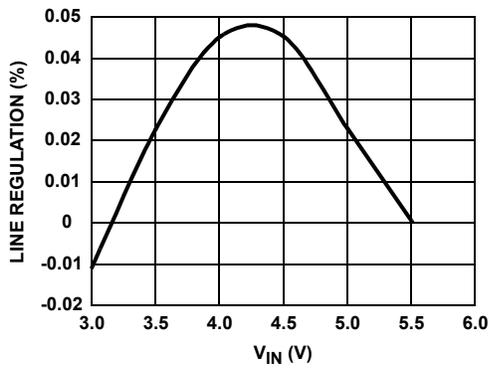


FIGURE 9.  $V_{\text{BOOST}}$  LINE REGULATION (PI MODE)

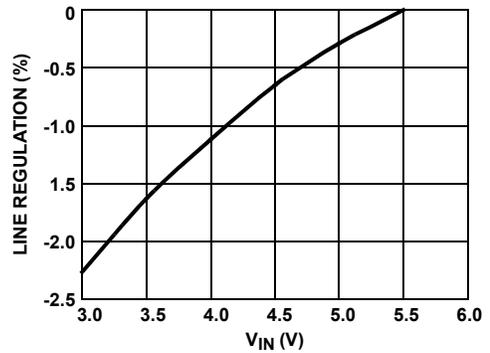


FIGURE 10.  $V_{\text{BOOST}}$  LINE REGULATION (P MODE)

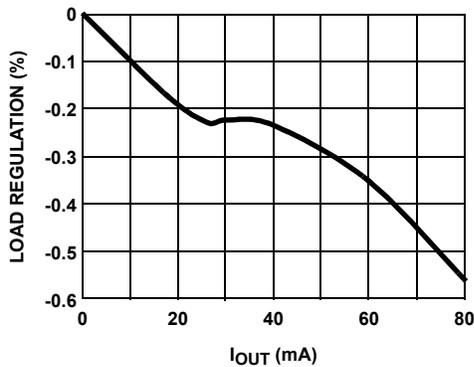


FIGURE 11.  $V_{\text{ON}}$  LOAD REGULATION

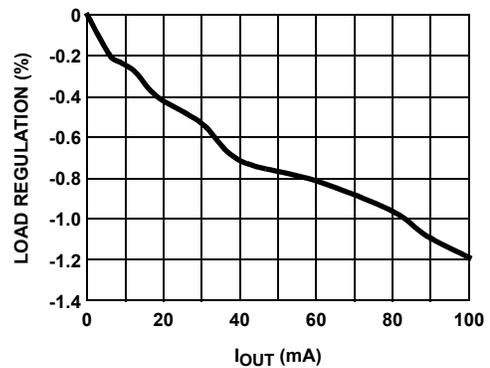


FIGURE 12.  $V_{\text{OFF}}$  LOAD REGULATION

# EL7586, EL7586A

## Typical Performance Curves (Continued)

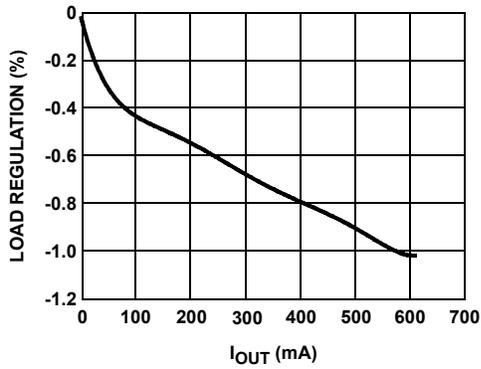


FIGURE 13. V<sub>LOGIC</sub> LOAD REGULATION

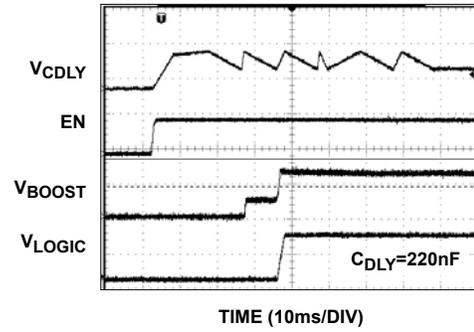


FIGURE 14. EL7586 START-UP SEQUENCE

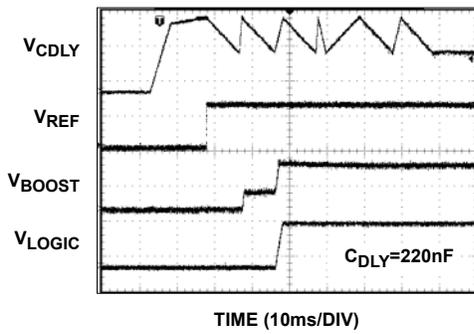


FIGURE 15. EL7586 START-UP SEQUENCE

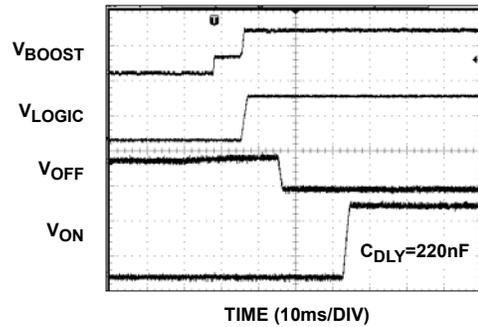


FIGURE 16. EL7586 START-UP SEQUENCE

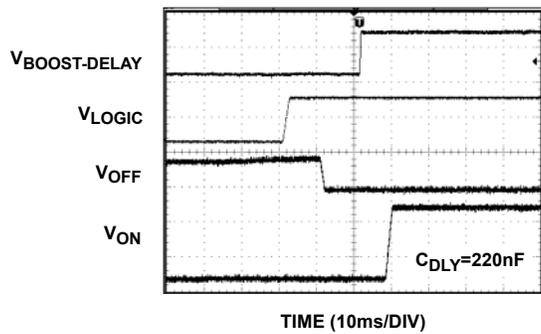


FIGURE 17. EL7586 START-UP SEQUENCE

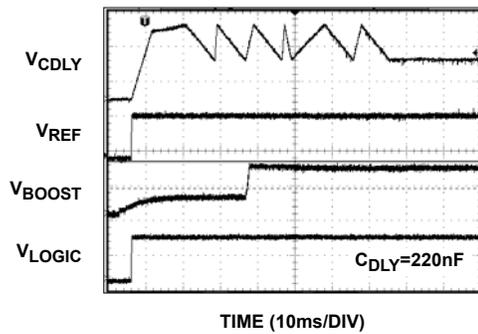


FIGURE 18. EL7586A START-UP SEQUENCE

# EL7586, EL7586A

## Typical Performance Curves (Continued)

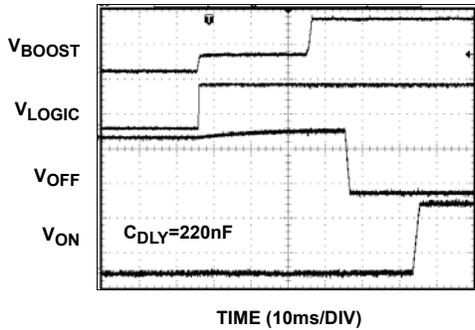


FIGURE 19. EL7586A START-UP SEQUENCE

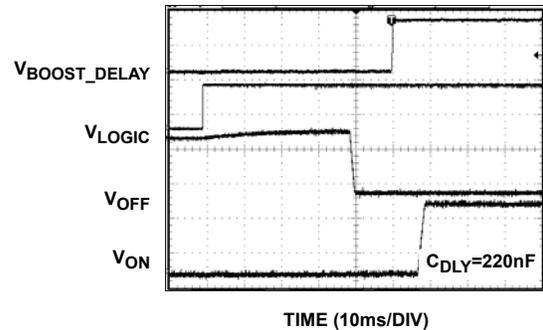


FIGURE 20. EL7586A START-UP SEQUENCE

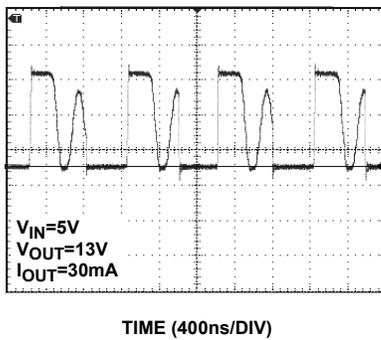


FIGURE 21. LX WAVEFORM - DISCONTINUOUS MODE

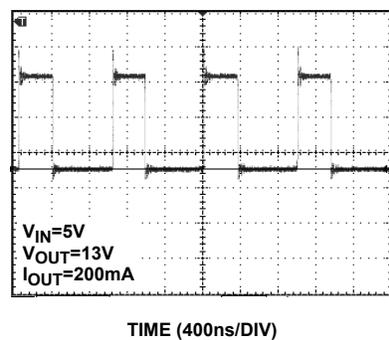


FIGURE 22. LX WAVEFORM - CONTINUOUS MODE

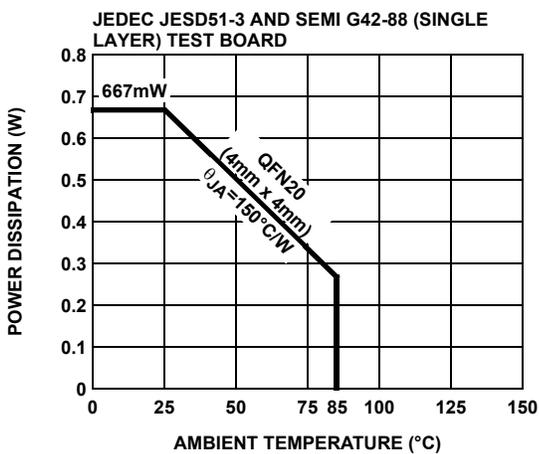


FIGURE 23. PACKAGE POWER DISSIPATION vs AMBIENT TEMPERATURE

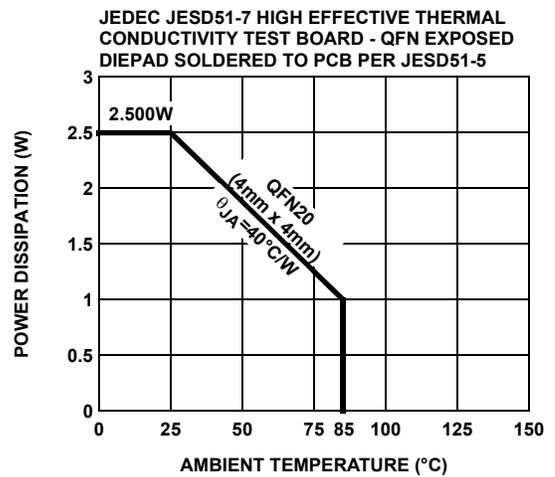


FIGURE 24. PACKAGE POWER DISSIPATION vs AMBIENT TEMPERATURE

## EL7586, EL7586A

### Applications Information

The EL7586 and EL7586A provide a high integrated multiple output power solution for TFT-LCD applications. The system consists of one high efficiency boost converter and three linear-regulator controllers ( $V_{ON}$ ,  $V_{OFF}$ , and  $V_{LOGIC}$ ) with multiple protection functions. A block diagram is shown in Figure 25. Table 1 lists the recommended components.

The EL7586, and EL7586A integrate an N-channel MOSFET boost converter to minimize external component count and cost. The  $A_{VDD}$ ,  $V_{ON}$ ,  $V_{OFF}$ , and  $V_{LOGIC}$  output voltages are independently set using external resistors.  $V_{ON}$ ,  $V_{OFF}$  voltages require external charge pumps which are post regulated using the integrated LDO controllers.

**TABLE 1. RECOMMENDED COMPONENTS**

DESIGNATION	DESCRIPTION
C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub>	10μF, 16V X7R ceramic capacitor (1206) TDK C3216X7R1C106M
C <sub>20</sub> , C <sub>31</sub>	4.7μF, 25V X5R ceramic capacitor (1206) TDK C3216X5R1A475K
D <sub>1</sub>	1A 20V low leakage Schottky rectifier (CASE 457-04) ON SEMI MBRM120ET3
D <sub>11</sub> , D <sub>12</sub> , D <sub>21</sub>	200mA 30V Schottky barrier diode (SOT-23) Fairchild BAT54S
L <sub>1</sub>	6.8μH 1.3A Inductor TDK SLF6025T-6R8M1R3-PF
Q <sub>1</sub>	-2.4 -20V P-channel 1.8V specified PowerTrench MOSFET (SuperSOT-3) Fairchild FDN304P
Q <sub>4</sub>	-2A -30V single P-channel logic level PowerTrench MOSFET (SuperSOT-3) Fairchild FDN360P
Q <sub>3</sub>	200mA 40V PNP amplifier (SOT-23) Fairchild MMBT3906
Q <sub>2</sub>	200mA 40V NPN amplifier (SOT-23) Fairchild MMBT3904
Q <sub>5</sub>	1A 30V PNP low saturation amplifier (SOT-23) Fairchild FM549

### Boost Converter

The main boost converter is a current mode PWM converter at a fixed frequency of 1MHz which enables the use of low profile inductors and multi-layer ceramic capacitors. This results in a compact, low cost power system for LCD panel design.

The EL7586 and EL7586A are designed for continuous current mode, but they can also operate in discontinuous current mode at light load. In continuous current mode, current flows continuously in the inductor during the entire switching cycle in steady state operation. The voltage conversion ratio in continuous current mode is given by:

$$\frac{A_{VDD}}{V_{IN}} = \frac{1}{1-D}$$

Where D is the duty cycle of the switching MOSFET.

Figure 26 shows the block diagram of the boost regulator. It uses a summing amplifier architecture consisting of GM stages for voltage feedback, current feedback and slope compensation. A comparator looks at the peak inductor current cycle by cycle and terminates the PWM cycle if the current limit is reached.

An external resistor divider is required to divide the output voltage down to the nominal reference voltage. Current drawn by the resistor network should be limited to maintain the overall converter efficiency. The maximum value of the resistor network is limited by the feedback input bias current and the potential for noise being coupled into the feedback pin. A resistor network in the order of 60kΩ is recommended. The boost converter output voltage is determined by the following equation:

$$A_{VDD} = \frac{R_1 + R_2}{R_1} \times V_{REF}$$

The current through the MOSFET is limited to 2A peak for the EL7586. This restricts the maximum output current based on the following equation:

$$I_{OMAX} = \left( I_{LMT} - \frac{\Delta I_L}{2} \right) \times \frac{V_{IN}}{V_O}$$

Where  $\Delta I_L$  is peak to peak inductor ripple current, and is set by:

$$\Delta I_L = \frac{V_{IN}}{L} \times \frac{D}{f_S}$$

where  $f_S$  is the switching frequency.

# EL7586, EL7586A

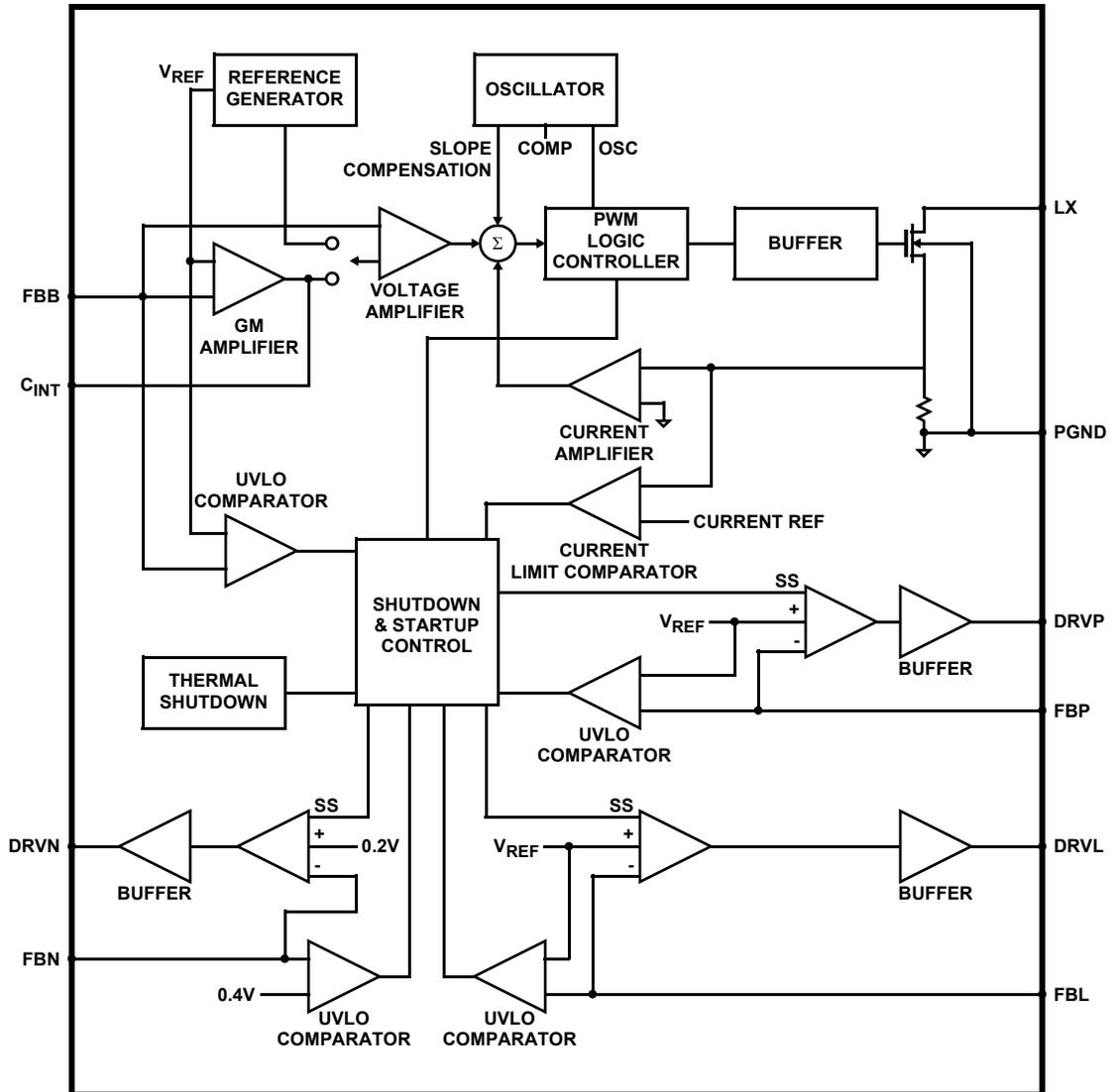


FIGURE 25. BLOCK DIAGRAM

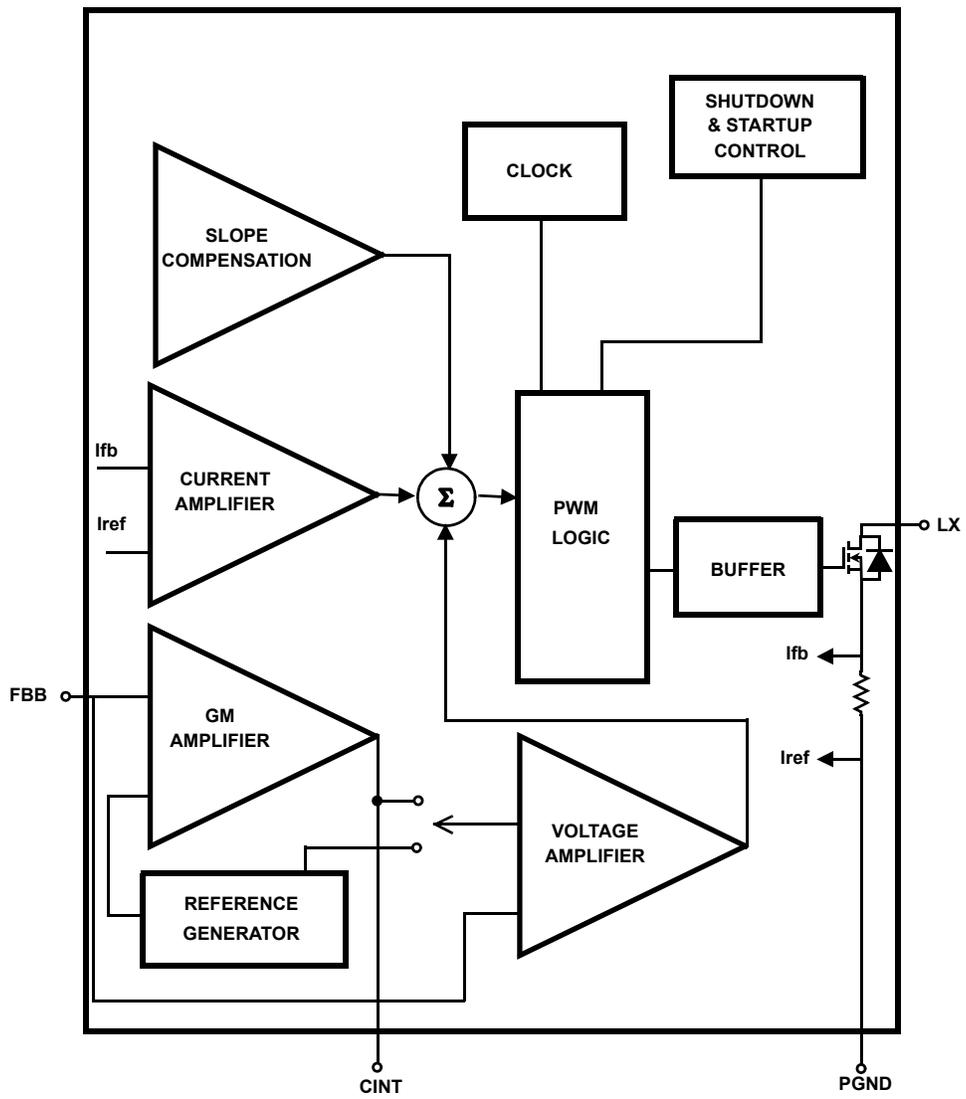


FIGURE 26. BLOCK DIAGRAM OF THE BOOST REGULATOR

## EL7586, EL7586A

The following table gives typical values (margins are considered 10%, 3%, 20%, 10%, and 15% on  $V_{IN}$ ,  $V_O$ ,  $L$ ,  $f_S$ , and  $I_{OMAX}$ ):

TABLE 2.

$V_{IN}$ (V)	$V_O$ (V)	$L$ ( $\mu$ H)	$f_S$ (MHz)	$I_{OMAX}$ (EL7586, EL7586A)
3.3	9	6.8	1	0.490686
3.3	12	6.8	1	0.307353
3.3	15	6.8	1	0.197353
5	9	6.8	1	0.743464
5	12	6.8	1	0.465686
5	15	6.8	1	0.29902

### Input Capacitor

An input capacitor is used to supply the peak charging current to the converter. It is recommended that  $C_{IN}$  be larger than  $10\mu$ F. The reflected ripple voltage will be smaller with larger  $C_{IN}$ . The voltage rating of input capacitor should be larger than maximum input voltage.

### Boost Inductor

The boost inductor is a critical part which influences the output voltage ripple, transient response, and efficiency. Values of  $3.3\mu$ H to  $10\mu$ H are to match the internal slope compensation. The inductor must be able to handle the following average and peak current:

$$I_{LAVG} = \frac{I_O}{1-D}$$

$$I_{LPK} = I_{LAVG} + \frac{\Delta I_L}{2}$$

### Rectifier Diode

A high-speed diode is necessary due to the high switching frequency. Schottky diodes are recommended because of their fast recovery time and low forward voltage. The rectifier diode must meet the output current and peak inductor current requirements.

### Output Capacitor

The output capacitor supplies the load directly and reduces the ripple voltage at the output. Output ripple voltage consists of two components: the voltage drop due to the inductor ripple current flowing through the ESR of output capacitor, and the charging and discharging of the output capacitor.

$$V_{RIPPLE} = I_{LPK} \times ESR + \frac{V_O - V_{IN}}{V_O} \times \frac{I_O}{C_{OUT}} \times \frac{1}{f_S}$$

For low ESR ceramic capacitors, the output ripple is dominated by the charging and discharging of the output

capacitor. The voltage rating of the output capacitor should be greater than the maximum output voltage.

NOTE: Capacitors have a voltage coefficient that makes their effective capacitance drop as the voltage across them increases.  $C_{OUT}$  in the equation above assumes the effective value of the capacitor at a particular voltage and not the manufacturer's stated value, measured at zero volts.

### Compensation

The EL7586, and EL7586A can operate in either P mode or PI mode. Connecting the  $C_{INT}$  pin directly to  $V_{IN}$  will enable P mode; For better load regulation, use PI mode with a  $4.7n$ F capacitor in series with a  $10K$  resistor between  $C_{INT}$  and ground. This value may be reduced to improve transient performance, however, very low values will reduce loop stability.

### Boost Feedback Resistors

As the boost output voltage,  $A_{VDD}$ , is reduced below  $12V$  the effective voltage feedback in the IC increases the ratio of voltage to current feedback at the summing comparator because  $R_2$  decreases relative to  $R_1$ . To maintain stable operation over the complete current range of the IC, the voltage feedback to the FBB pin should be reduced proportionally, as  $A_{VDD}$  is reduced, by means of a series resistor-capacitor network ( $R_7$  and  $C_7$ ) in parallel with  $R_1$ , with a pole frequency ( $f_p$ ) set to approximately  $10kHz$  for  $C_2$  effective =  $10\mu$ F and  $4kHz$  for  $C_2$  (effective) =  $30\mu$ F.

$$R_7 = ((1/0.1 \times R_2) - 1/R_1)^{-1}$$

$$C_7 = 1/(2 \times 3.142 \times f_p \times R_7)$$

### PI mode $C_{INT}$ ( $C_{23}$ ) and $R_{INT}$ ( $R_{10}$ )

The IC is designed to operate with a minimum  $C_{23}$  capacitor of  $4.7n$ F and a minimum  $C_2$  (effective) =  $10\mu$ F.

Note that, for high voltage  $A_{VDD}$ , the voltage coefficient of ceramic capacitors ( $C_2$ ) reduces their effective capacitance greatly; a  $16V$   $10\mu$ F ceramic can drop to around  $3\mu$ F at  $15V$ .

To improve the transient load response of  $A_{VDD}$  in PI mode, a resistor may be added in series with the  $C_{23}$  capacitor. The larger the resistor the lower the overshoot but at the expense of stability of the converter loop - especially at high currents.

With  $L = 10\mu$ H,  $A_{VDD} = 15V$ ,  $C_{23} = 4.7n$ F,  $C_2$  (effective) should have a capacitance of greater than  $10\mu$ F.  $R_{INT}$  ( $R_7$ ) can have values up to  $5k\Omega$  for  $C_2$  (effective) up to  $20\mu$ F and up to  $10K$  for  $C_2$  (effective) up to  $30\mu$ F.

Larger values of  $R_{INT}$  ( $R_7$ ) may be possible if maximum  $A_{VDD}$  load currents less than the current limit are used. To ensure  $A_{VDD}$  stability, the IC should be operated at the maximum desired current and then the transient load response of  $A_{VDD}$  should be used to determine the maximum value of  $R_{INT}$ .

## EL7586, EL7586A

### Cascaded MOSFET Application

A 20V N-channel MOSFET is integrated in the boost regulator. For the applications where the output voltage is greater than 20V, an external cascaded MOSFET is needed as shown in Figure 27. The voltage rating of the external MOSFET should be greater than  $V_{BOOST}$ .

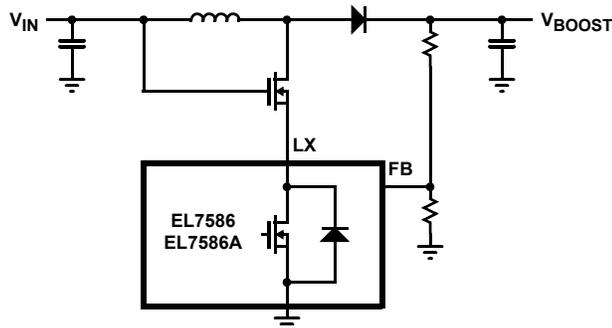


FIGURE 27. CASCADED MOSFET TOPOLOGY FOR HIGH OUTPUT VOLTAGE APPLICATIONS

### Linear-Regulator Controllers ( $V_{ON}$ , $V_{LOGIC}$ , and $V_{OFF}$ )

The EL7586 and EL7586A include three independent linear-regulator controllers, in which two are positive output voltage ( $V_{ON}$  and  $V_{LOGIC}$ ), and one is negative. The  $V_{ON}$ ,  $V_{OFF}$ , and  $V_{LOGIC}$  linear-regulator controller functional diagrams, applications circuits are shown in Figures 28, 29, and 30 respectively.

### Calculation of the Linear Regulator Base-Emitter Resistors ( $R_{BL}$ , $R_{BP}$ and $R_{BN}$ )

For the pass transistor of the linear regulator, low frequency gain ( $H_{fe}$ ) and unity gain freq. ( $f_T$ ) are usually specified in the datasheet. The pass transistor adds a pole to the loop transfer function at  $f_p = f_T/H_{fe}$ . Therefore, in order to maintain phase margin at low frequency, the best choice for a pass device is often a high frequency low gain switching transistor. Further improvement can be obtained by adding a base-emitter resistor  $R_{BE}$  ( $R_{BP}$ ,  $R_{BL}$ ,  $R_{BN}$  in the Functional Block Diagram), which increase the pole frequency to:  $f_p = f_T \cdot (1 + H_{fe} \cdot r_e/R_{BE})/H_{fe}$ , where  $r_e = KT/qI_C$ . So choose the lowest value  $R_{BE}$  in the design as long as there is still enough base current ( $I_B$ ) to support the maximum output current ( $I_C$ ).

We will take as an example the  $V_{LOGIC}$  linear regulator. If a Fairchild FMMT549 PNP transistor is used as the external pass transistor, Q5 in the application diagram, then for a maximum  $V_{LOGIC}$  operating requirement of 500mA the data sheet indicates  $H_{fe\_min} = 100$ .

The base-emitter saturation voltage is:  $V_{be\_max} = 1.25V$  (note this is normally a  $V_{be} \sim 0.7V$ , however, for the Q5 transistor an internal Darlington arrangement is used to increase it's current gain, giving a 'base-emitter' voltage of  $2 \times V_{BE}$ ).

(Note that using a high current Darlington PNP transistor for Q5 requires that  $V_{IN} > V_{LOGIC} + 2V$ . Should a lower input voltage be required, then an ordinary high gain PNP transistor should be selected for Q5 so as to allow a lower collector-emitter saturation voltage).

For the EL7586 and EL7586A, the minimum drive current is:  $I_{DRVL\_min} = 8mA$

The minimum base-emitter resistor,  $R_{BL}$ , can now be calculated as:

$$R_{BL\_min} = V_{BE\_max}/(I_{DRVL\_min} - I_C/H_{fe\_min}) = 1.25V/(8mA - 500mA/100) = 417\Omega$$

This is the minimum value that can be used - so, we now choose a convenient value greater than this minimum value; say  $500\Omega$ . Larger values may be used to reduce quiescent current, however, regulation may be adversely affected, by supply noise if  $R_{BL}$  is made too high in value.

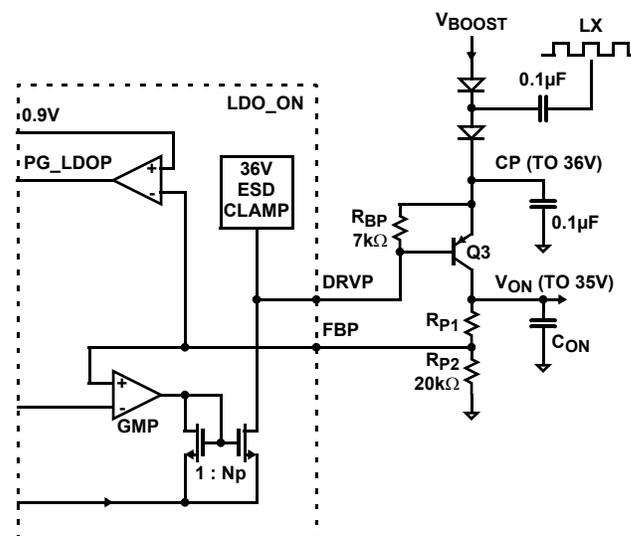


FIGURE 28.  $V_{ON}$  FUNCTIONAL BLOCK DIAGRAM

## EL7586, EL7586A

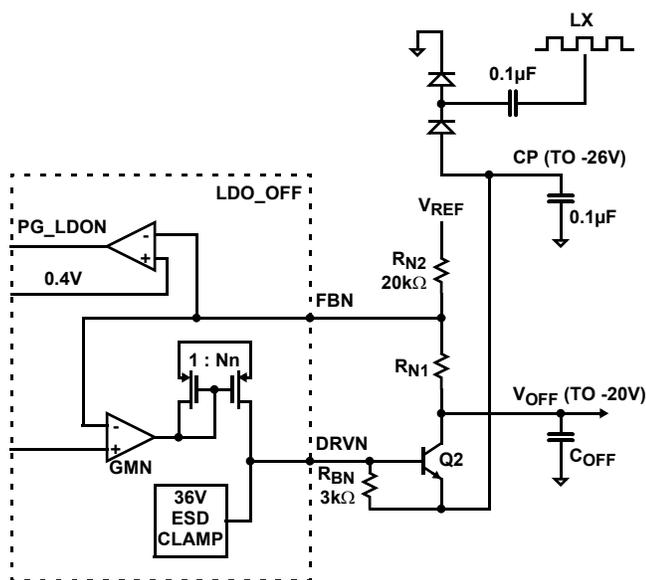


FIGURE 29.  $V_{OFF}$  FUNCTIONAL BLOCK DIAGRAM

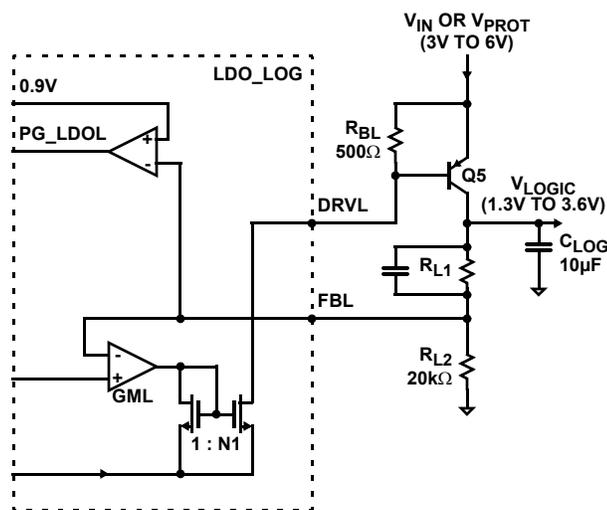


FIGURE 30.  $V_{LOGIC}$  FUNCTIONAL BLOCK DIAGRAM

The  $V_{ON}$  power supply is used to power the positive supply of the row driver in the LCD panel. The DC/DC consists of an external diode-capacitor charge pump powered from the inductor (LX) of the boost converter, followed by a low dropout linear regulator (LDO\_ON). The LDO\_ON regulator uses an external PNP transistor as the pass element. The onboard LDO controller is a wide band (>10MHz) transconductance amplifier capable of 4mA drive current, which is sufficient for up to 40mA or more output current under the low dropout condition (forced beta of 10). Typical  $V_{ON}$  voltage supported by EL7586 and EL7586A ranges from +15V to +36V. A fault comparator is also included for monitoring the output voltage. The undervoltage threshold is set at 25% below the 1.2V reference.

The  $V_{OFF}$  power supply is used to power the negative supply of the row driver in the LCD panel. The DC/DC

consists of an external diode-capacitor charge pump powered from the inductor (LX) of the boost converter, followed by a low dropout linear regulator (LDO\_OFF). The LDO\_OFF regulator uses an external NPN transistor as the pass element. The onboard LDO controller is a wide band (>10MHz) transconductance amplifier capable of 4mA drive current, which is sufficient for up to 40mA or more output current under the low dropout condition (forced beta of 10). Typical  $V_{OFF}$  voltage supported by EL7586 and EL7586A ranges from -5V to -20V. A fault comparator is also included for monitoring the output voltage. The undervoltage threshold is set at 200mV above the 0.2V reference level.

The  $V_{LOGIC}$  power supply is used to power the logic circuitry within the LCD panel. The DC/DC may be powered directly from the low voltage input, 3.3V or 5.0V, or it may be powered through the fault protection switch. The LDO\_LOGIC regulator uses an external PNP transistor as the pass element. The onboard LDO controller is a wide band (>10MHz) transconductance amplifier capable of 16mA drive current, which is sufficient for up to 160mA or more output current under the low dropout condition (forced beta of 10). Typical  $V_{LOGIC}$  voltage supported by EL7586 and EL7586A ranges from +1.3V to  $V_{DD}-0.2V$ . A fault comparator is also included for monitoring the output voltage. The undervoltage threshold is set at 25% below the 1.2V reference.

### Set-Up Output Voltage

Refer to the Typical Application Diagram, the output voltages of  $V_{ON}$ ,  $V_{OFF}$ , and  $V_{LOGIC}$  are determined by the following equations:

$$V_{ON} = V_{REF} \times \left( 1 + \frac{R_{12}}{R_{11}} \right)$$

$$V_{OFF} = V_{REFN} + \frac{R_{22}}{R_{21}} \times (V_{REFN} - V_{REF})$$

$$V_{LOGIC} = V_{REF} \times \left( 1 + \frac{R_{42}}{R_{41}} \right)$$

Where  $V_{REF} = 1.2V$ ,  $V_{REFN} = 0.2V$ .

Resistor networks in the order of 250kΩ, 120kΩ and 10kΩ are recommended for  $V_{ON}$ ,  $V_{OFF}$  and  $V_{LOGIC}$ , respectively.

### Charge Pump

To generate an output voltage higher than  $V_{BOOST}$ , single or multiple stages of charge pumps are needed. The number of stage is determined by the input and output voltage. For positive charge pump stages:

$$N_{POSITIVE} \geq \frac{V_{OUT} + V_{CE} - V_{INPUT}}{V_{INPUT} - 2 \times V_F}$$

where  $V_{CE}$  is the dropout voltage of the pass component of the linear regulator. It ranges from 0.3V to 1V depending on

## EL7586, EL7586A

the transistor.  $V_F$  is the forward-voltage of the charge pump rectifier diode.

The number of negative charge pump stages is given by:

$$N_{\text{NEGATIVE}} \geq \frac{|V_{\text{OUTPUT}}| + V_{\text{CE}}}{V_{\text{INPUT}} - 2 \times V_F}$$

To achieve high efficiency and low material cost, the lowest number of charge pump stages which can meet the above requirements, is always preferred.

### High Charge Pump Output Voltage (>36V) Applications

In the applications where the charge pump output voltage is over 36V, an external npn transistor need to be inserted into between DRVP pin and base of pass transistor Q3 as shown in Figure 31; or the linear regulator can control only one stage charge pump and regulate the final charge pump output as shown in Figure 32.

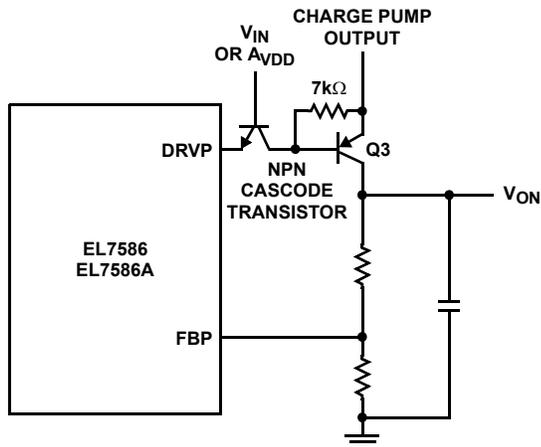


FIGURE 31. CASCODE NPN TRANSISTOR CONFIGURATION FOR HIGH CHARGE PUMP OUTPUT VOLTAGE (>36V)

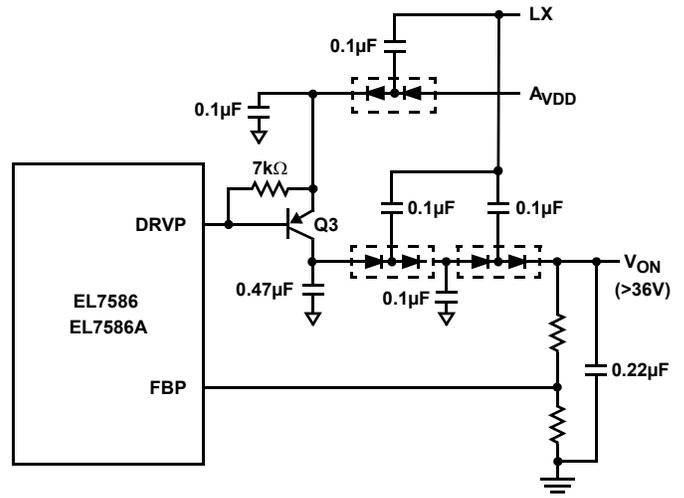


FIGURE 32. THE LINEAR REGULATOR CONTROLS ONE STAGE OF CHARGE PUMP

### Discontinuous/Continuous Boost Operation and its Effect on the Charge Pumps

The EL7586 and EL7586A  $V_{\text{ON}}$  and  $V_{\text{OFF}}$  architecture uses LX switching edges to drive diode charge pumps from which LDO regulators generate the  $V_{\text{ON}}$  and  $V_{\text{OFF}}$  supplies. It can be appreciated that should a regular supply of LX switching edges be interrupted, for example during discontinuous operation at light  $A_{\text{VDD}}$  boost load currents, then this may affect the performance of  $V_{\text{ON}}$  and  $V_{\text{OFF}}$  regulation - depending on their exact loading conditions at the time.

To optimize  $V_{\text{ON}}/V_{\text{OFF}}$  regulation, the boundary of discontinuous/continuous operation of the boost converter can be adjusted, by suitable choice of inductor given  $V_{\text{IN}}$ ,  $V_{\text{OUT}}$ , switching frequency and the  $A_{\text{VDD}}$  current loading, to be in continuous operation.

The following equation gives the boundary between discontinuous and continuous boost operation. For continuous operation (LX switching every clock cycle) we require that:

$$I(A_{\text{VDD\_load}}) > D \cdot (1-D) \cdot V_{\text{IN}} / (2 \cdot L \cdot F_{\text{OSC}})$$

where the duty cycle,  $D = (A_{\text{VDD}} - V_{\text{IN}}) / A_{\text{VDD}}$

For example, with  $V_{\text{IN}} = 5\text{V}$ ,  $F_{\text{OSC}} = 1.0\text{MHz}$  and  $A_{\text{VDD}} = 12\text{V}$  we find continuous operation of the boost converter can be guaranteed for:

$$L = 10\mu\text{H} \text{ and } I(A_{\text{VDD}}) > 61\text{mA}$$

$$L = 6.8\mu\text{H} \text{ and } I(A_{\text{VDD}}) > 89\text{mA}$$

$$L = 3.3\mu\text{H} \text{ and } I(A_{\text{VDD}}) > 184\text{mA}$$

## Charge Pump Output Capacitors

Ceramic capacitors with low ESR are recommended. With ceramic capacitors, the output ripple voltage is dominated by the capacitance value. The capacitance value can be chosen by the following equation:

$$C_{OUT} \geq \frac{I_{OUT}}{2 \times V_{RIPPLE} \times f_{OSC}}$$

where  $f_{OSC}$  is the switching frequency.

## Start-Up Sequence

Figure 33 and 34 show a detailed start-up sequence waveform. For a successful power up, there should be six peaks at  $V_{CDLY}$ . When a fault is detected, the device will latch off until either EN is toggled or the input supply is recycled.

When the input voltage is higher than 2.5V, an internal current source starts to charge  $C_{CDLY}$  to an upper threshold using a fast ramp followed by a slow ramp. During the initial slow ramp, the device checks whether there is a fault condition. If no fault is found,  $C_{CDLY}$  is discharged after the first peak and  $V_{REF}$  turns on.

During the second ramp, the device checks the status of  $V_{REF}$  and over temperature. At the peak of the second ramp, PG output goes low and enables the input protection PMOS Q1. Q1 is a controlled FET used to prevent in-rush current into  $V_{BOOST}$  before  $V_{BOOST}$  is enabled internally. Its rate of turn on is controlled by  $C_0$ . When a fault is detected, M1 will turn off and disconnect the inductor from  $V_{IN}$ .

With the input protection FET on, NODE1 (See Typical Application Diagram) will rise to  $\sim V_{IN}$ . Initially the boost is not enabled so  $V_{BOOST}$  rises to  $V_{IN} - V_{DIODE}$  through the output diode. Hence, there is a step at  $V_{BOOST}$  during this part of the start-up sequence. If this step is not desirable, an external PMOS FET can be used to delay the output until the boost is enabled internally. The delayed output appears at  $A_{VDD}$ .

For the EL7586,  $V_{BOOST}$  and  $V_{LOGIC}$  soft-start at the beginning of the third ramp. The soft-start ramp depends on the value of the  $C_{DLY}$  capacitor. For  $C_{DLY}$  of 220nF, the soft-start time is  $\sim 2ms$ .

The EL7586A is the same as the EL7586 except  $V_{REF}$  and  $V_{LOGIC}$  turn on when input voltage ( $V_{DD}$ ) exceeds 2.5V. When a fault is detected, the outputs and the input protection will turn off but  $V_{REF}$  will stay on.

$V_{OFF}$  turns on at the start of the fourth peak. At the fifth peak, DELB gate goes low to turn on the external PMOS Q4 to generate a delayed  $V_{BOOST}$  output.

$V_{ON}$  is enabled at the beginning of the sixth ramp.  $A_{VDD}$ , PG,  $V_{OFF}$ , DELB and  $V_{ON}$  are checked at end of this ramp.

## Fault Protection

Once the start-up sequence is complete, the voltage on the  $C_{DLY}$  capacitor remains at 1.15V until either a fault is detected or the EN pin is disabled. If a fault is detected, the voltage on  $C_{DLY}$  rises to 2.4V at which point the chip is disabled until the power is recycled or enable is toggled.

## Component Selection for Start-Up Sequencing and Fault Protection

The  $C_{REF}$  capacitor is typically set at 220nF and is required to stabilize the  $V_{REF}$  output. The range of  $C_{REF}$  is from 22nF to 1 $\mu$ F and should not be more than five times the capacitor on  $C_{DEL}$  to ensure correct start-up operation.

The  $C_{DEL}$  capacitor is typically 220nF and has a usable range from 47nF minimum to several microfarads - only limited by the leakage in the capacitor reaching  $\mu$ A levels.

$C_{DEL}$  should be at least 1/5 of the value of  $C_{REF}$  (See above). Note with 220nF on  $C_{DEL}$  the fault time-out will be typically 50ms and the use of a larger/smaller value will vary this time proportionally (e.g. 1 $\mu$ F will give a fault time-out period of typically 230ms).

## Fault Sequencing

The EL7586 and EL7586A have advanced fault detection systems which protects the IC from both adjacent pin shorts during operation and shorts on the output supplies.

A high quality layout/design of the PCB, in respect of grounding quality and decoupling is necessary to avoid falsely triggering the fault detection scheme - especially during start-up. The user is directed to the layout guidelines and component selection sections to avoid problems during initial evaluation and prototype PCB generation.

# EL7586, EL7586A

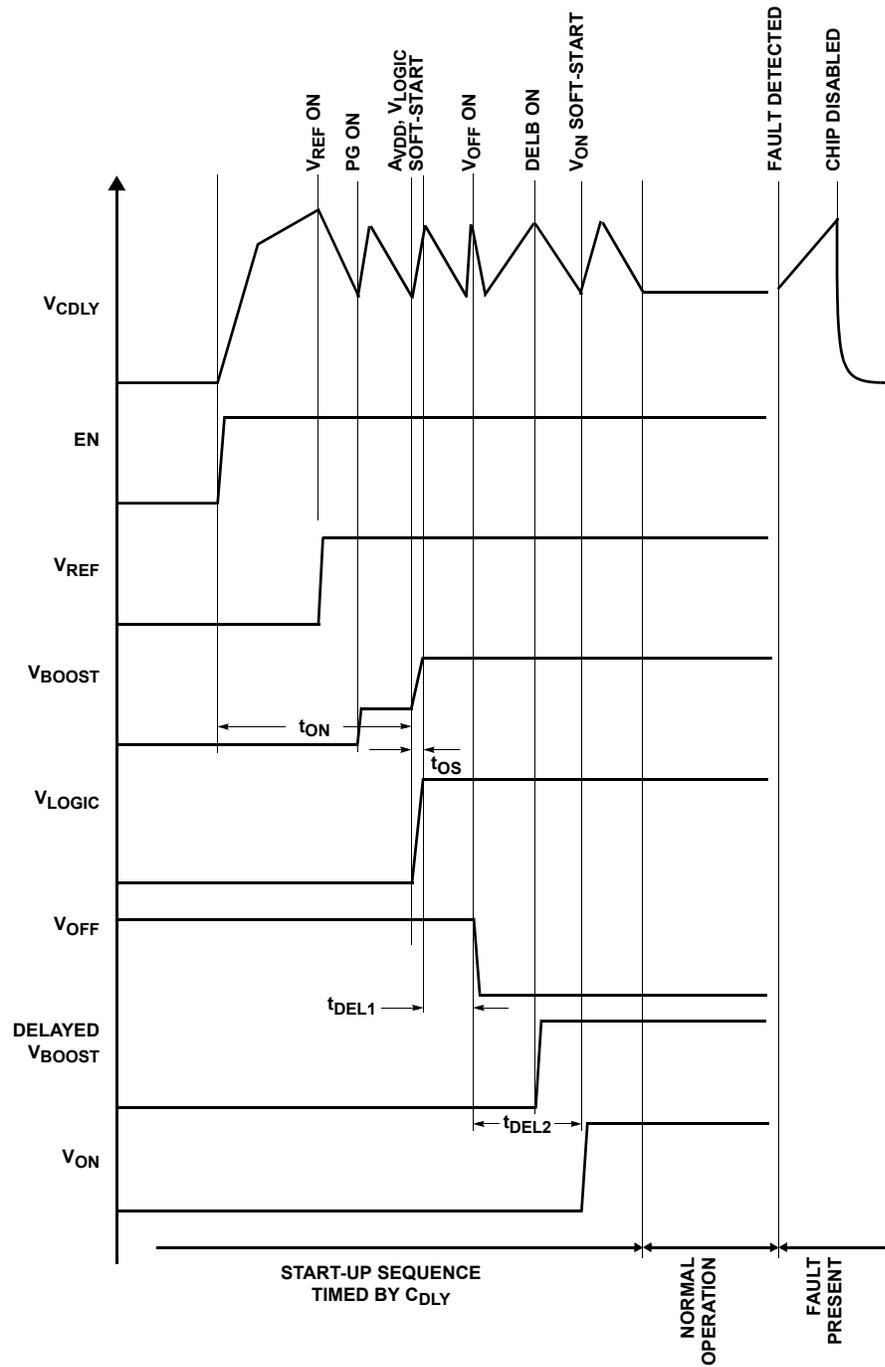


FIGURE 33. EL7586 START-UP SEQUENCE

# EL7586, EL7586A

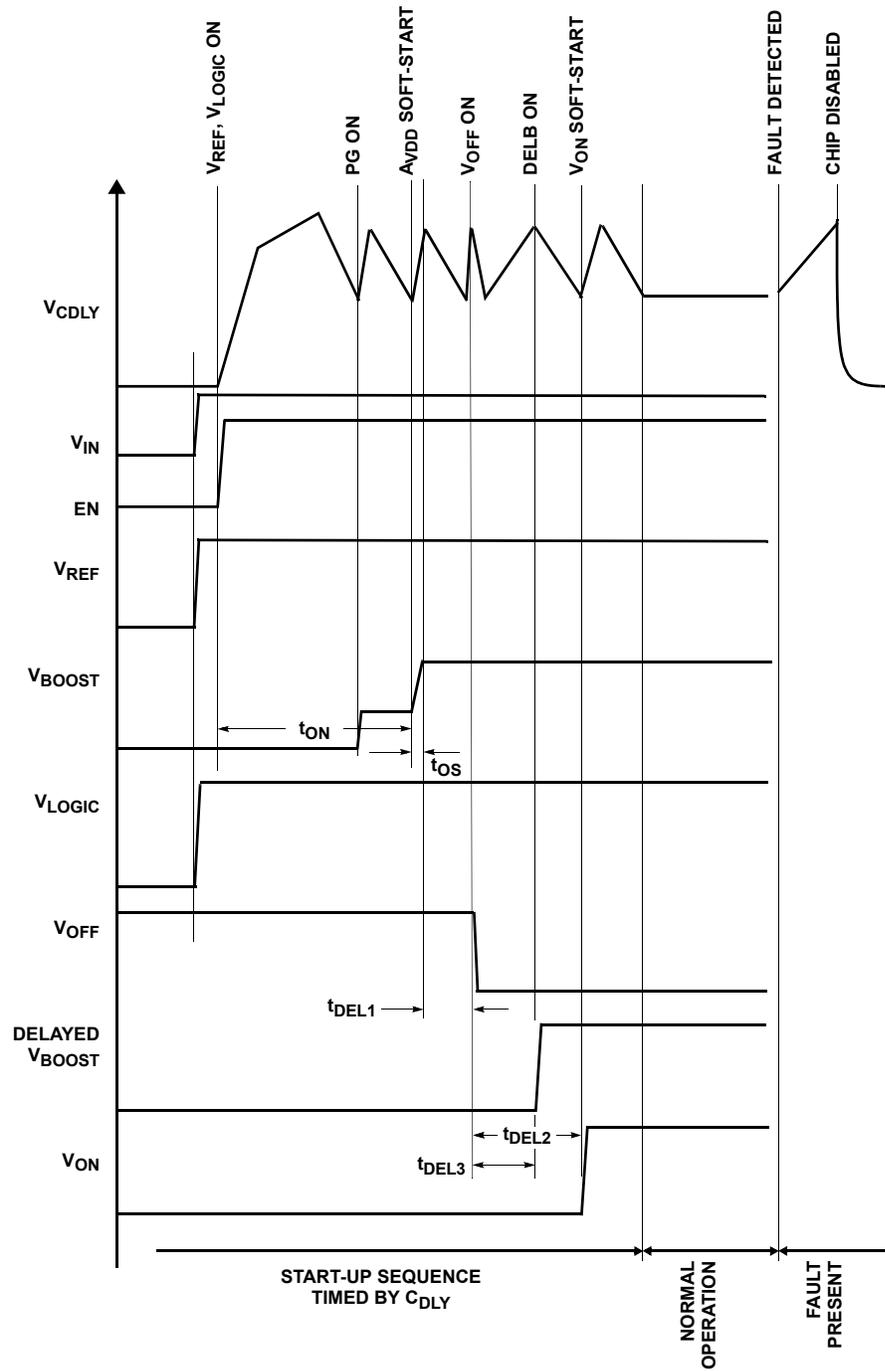


FIGURE 34. EL7586A START-UP SEQUENCE

### Over-Temperature Protection

An internal temperature sensor continuously monitors the die temperature. In the event that the die temperature exceeds the thermal trip point of 140°C, the device will shut down.

### Layout Recommendation

The device's performance including efficiency, output noise, transient response and control loop stability is dramatically affected by the PCB layout. PCB layout is critical, especially at high switching frequency.

There are some general guidelines for layout:

1. Place the external power components (the input capacitors, output capacitors, boost inductor and output diodes, etc.) in close proximity to the device. Traces to these components should be kept as short and wide as possible to minimize parasitic inductance and resistance.
2. Place  $V_{REF}$  and  $V_{DD}$  bypass capacitors close to the pins.
3. Minimize the length of traces carrying fast signals and high current.
4. All feedback networks should sense the output voltage directly from the point of load, and be as far away from LX node as possible.
5. The power ground (PGND) and signal ground (SGND) pins should be connected at only one point near the main decoupling capacitors.
6. The exposed die plate, on the underneath of the package, should be soldered to an equivalent area of metal on the PCB. This contact area should have multiple via connections to the back of the PCB as well as connections to intermediate PCB layers, if available, to maximize thermal dissipation away from the IC.
7. To minimize the thermal resistance of the package when soldered to a multi-layer PCB, the amount of copper track and ground plane area connected to the exposed die plate should be maximized and spread out as far as possible from the IC. The bottom and top PCB areas especially should be maximized to allow thermal dissipation to the surrounding air.
8. A signal ground plane, separate from the power ground plane and connected to the power ground pins only at the exposed die plate, should be used for ground return connections for feedback resistor networks ( $R_1$ ,  $R_{11}$ ,  $R_{41}$ ) and the  $V_{REF}$  capacitor,  $C_{22}$ , the  $C_{DELAY}$  capacitor  $C_7$  and the integrator capacitor  $C_{23}$ .
9. Minimize feedback input track lengths to avoid switching noise pick-up.

A demo board is available to illustrate the proper layout implementation.

### Demo Board Layout

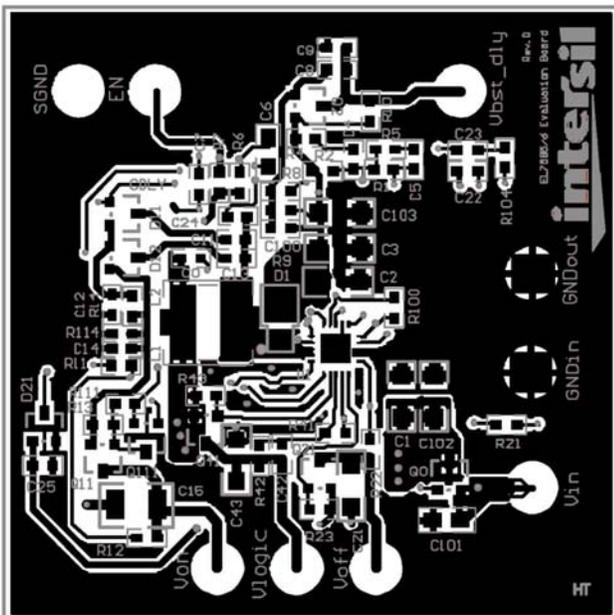


FIGURE 35. TOP LAYER

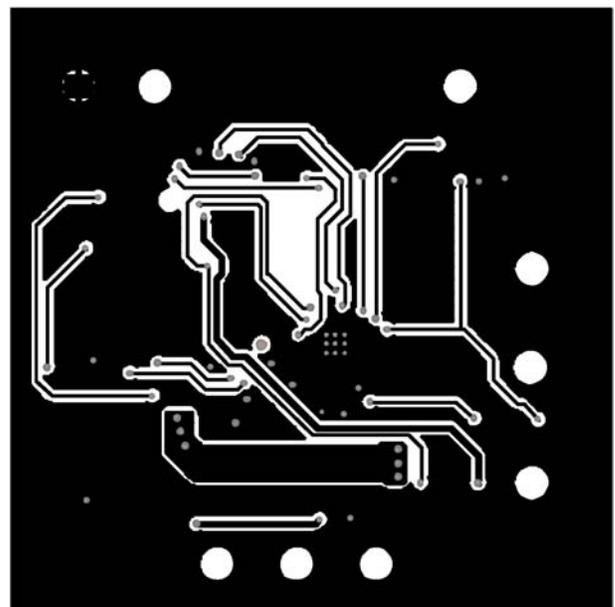
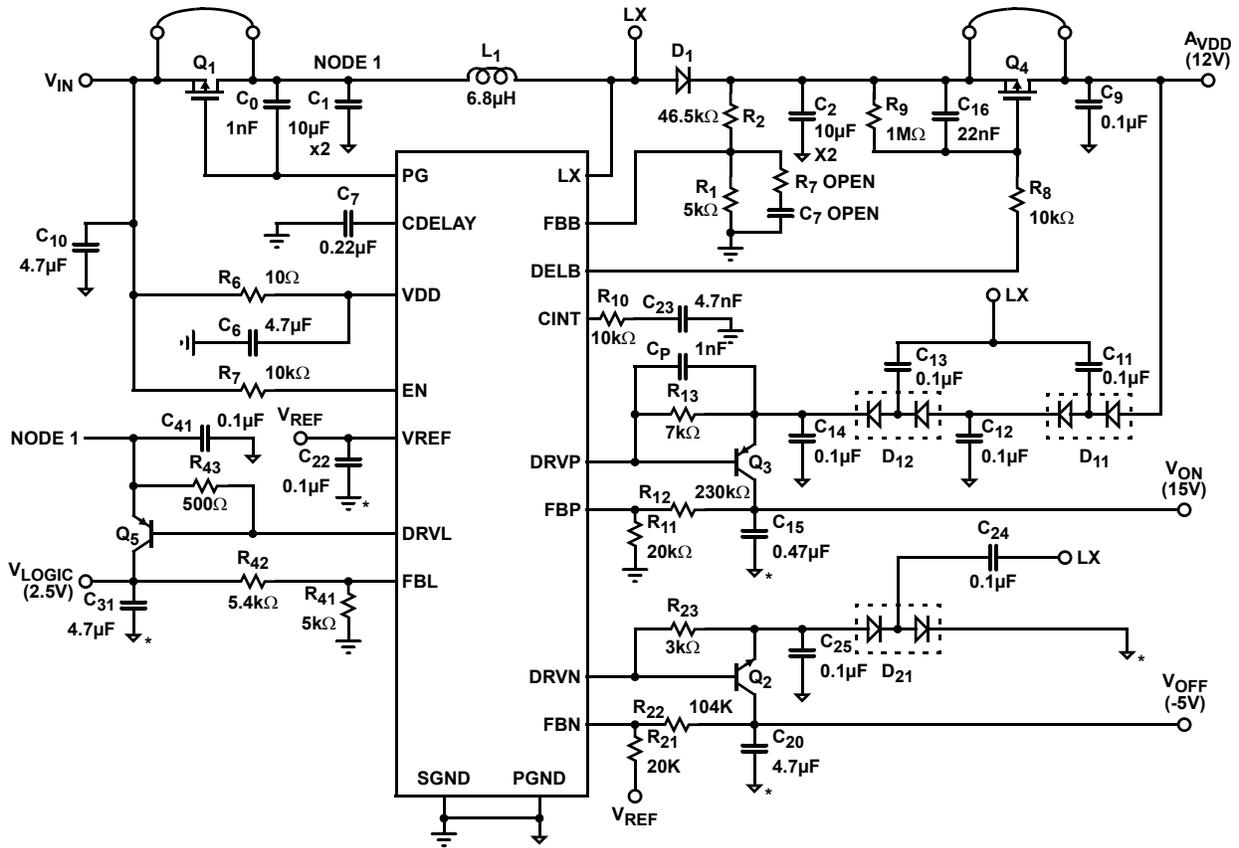


FIGURE 36. BOTTOM LAYER

# EL7586, EL7586A

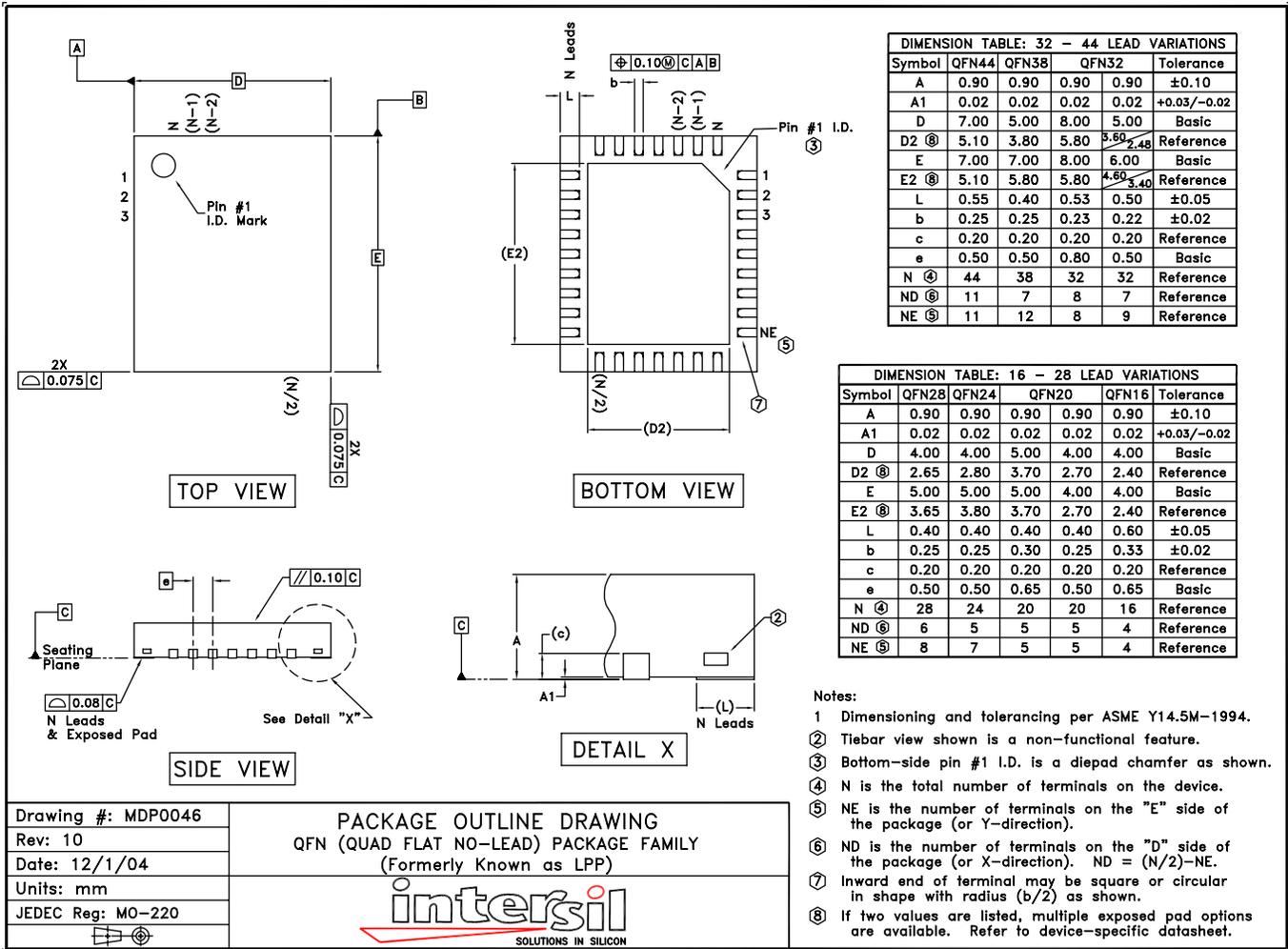
## Typical Application Diagram



NOTE: The SGND should be connected to the exposed die plate and connectd to the PGND at one point only.

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## QFN Package Outline Drawing



NOTE: The package drawing shown here may not be the latest version. To check the latest revision, please refer to the Intersil website at <http://www.intersil.com/design/packages/index.asp>

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